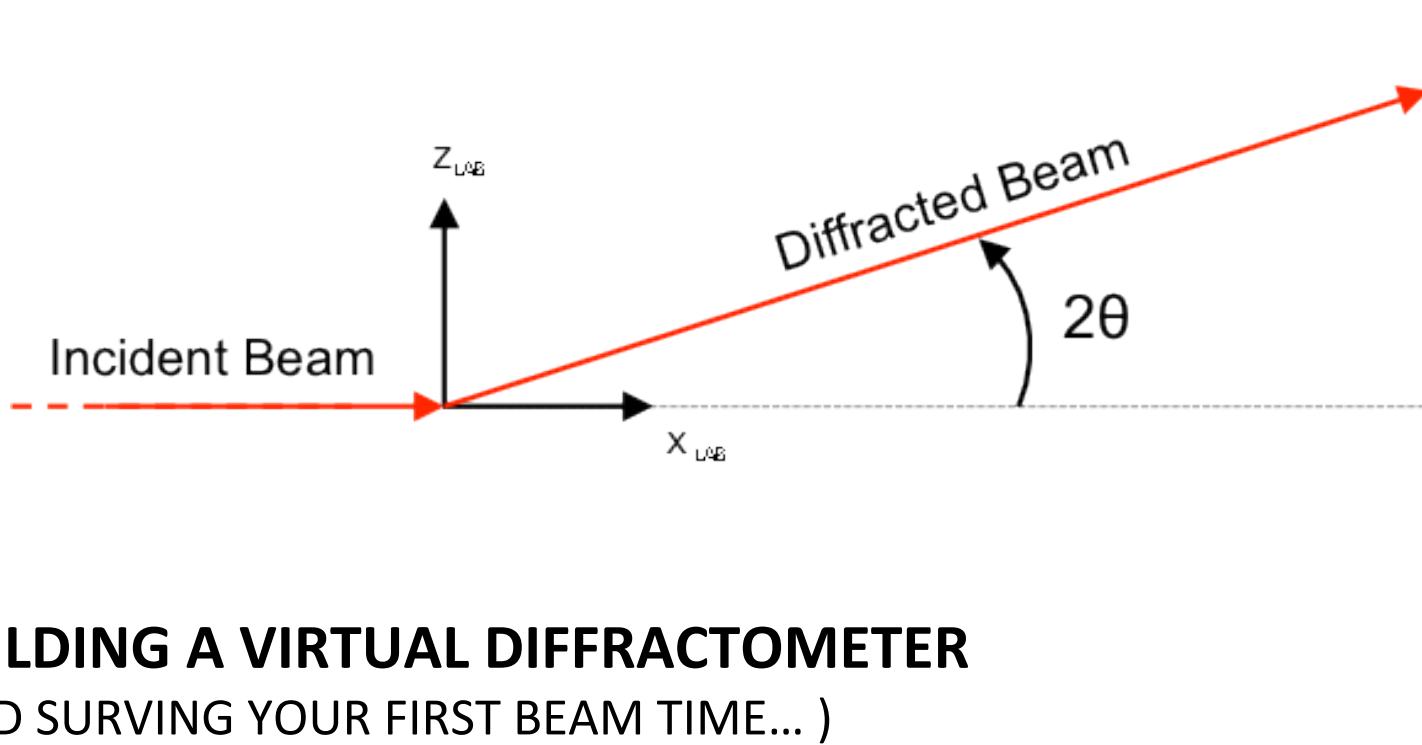




X-ray Area Detector



## BUILDING A VIRTUAL DIFFRACTOMETER

(AND SURVIVING YOUR FIRST BEAM TIME... )

Euan Wielewski and Matt Miller  
*Cornell University*



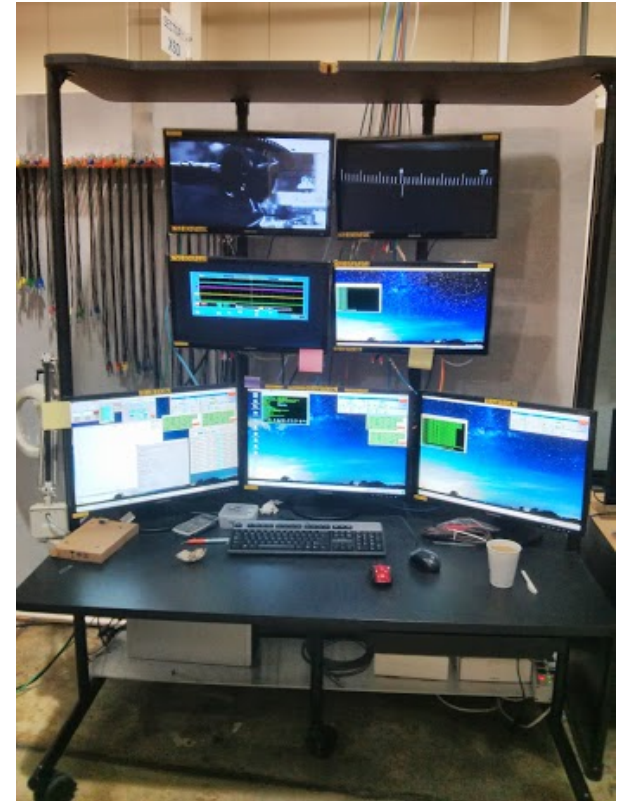
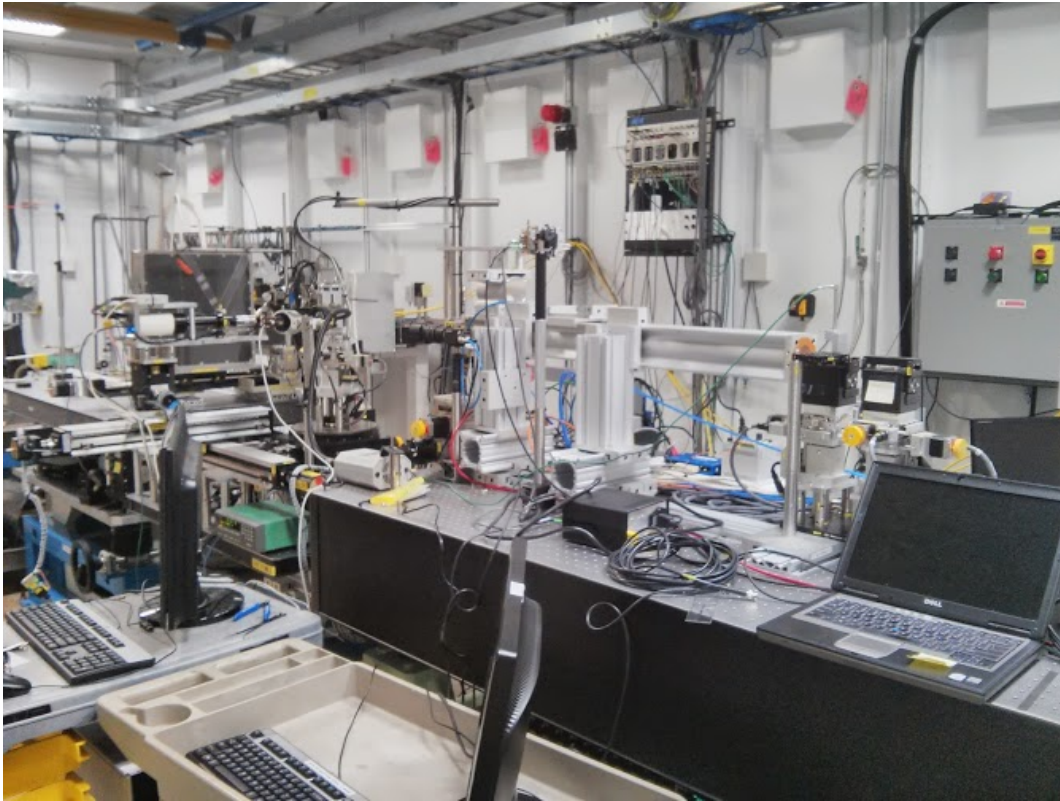
## ACKNOWLEDGEMENTS:

- Prof. Matt Miller (Cornell)
- Prof. Paul Dawson (Cornell)
- Prof. Bob Suter (CMU)
- Dr Jun-Sang Park (APS)
- Dr Joel Bernier (LLNL)
- Dr Jay Schuren (AFRL)
- Dr Frankie Li (LLNL)
- Dr Ulrich Lienert (DESY)
- Dr Jon Lind (CMU)
- Don Boyce (Cornell)
- Darren Pagan (Cornell)
- Mark Obstalecki (Cornell)
- ...

These are just the people that have directly helped me but there are dozens of other people who worked on developing these techniques who I don't have space to acknowledge here.



## SYNCHROTRONS CAN BE PRETTY INTIMIDATING:



**Sector 1-ID E-Hutch at the APS**



## DON'T WORRY ABOUT IT:

- There are amazing beam line scientists on hand to help you.
- There is a strong (but small) community that is always willing to help you.
- Some very smart people have done a lot of hard thinking and solved most of the really difficult problems.
- As a result, there is a wide range of sources available to help you understand analysis techniques (the hand out has some references).
- There are even some software packages available that will do a lot of the work for you:
  - FABLE
  - HEXRD
  - Fit2D
  - ...



## THAT BEING SAID...

- Beam time can be tough.
- Synchrotron facilities generally run 24/7 during up time.
- If you aren't collecting data then those expensive photons are wasted.
- Ideally you need a team of people (4-5) that are willing to put in very long hours.



**THESE WILL BECOME YOUR BEST FRIENDS:**





## **Previously, the barrier to entry was...**

- The extremely difficult nature of the experiments!

## **Now, the barrier to entry is...**

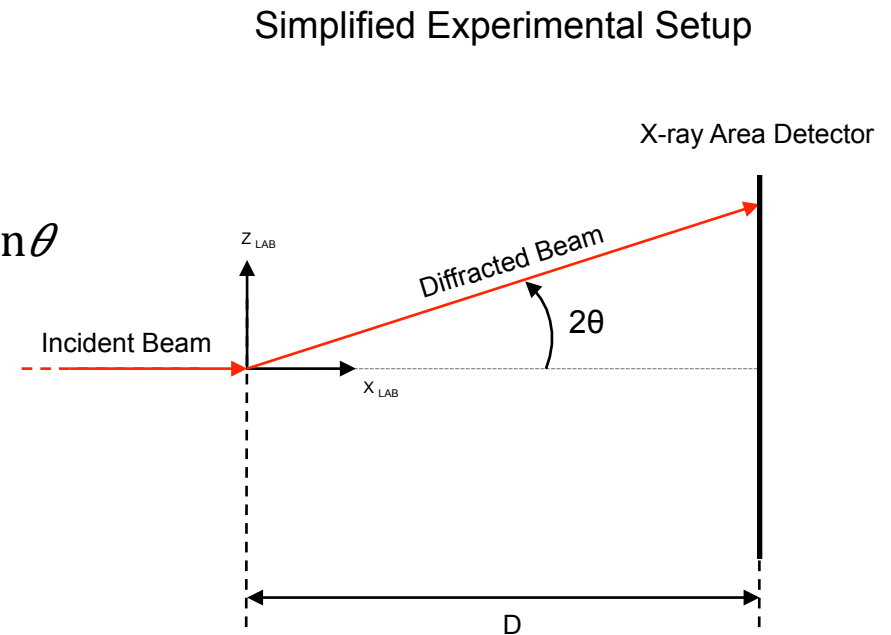
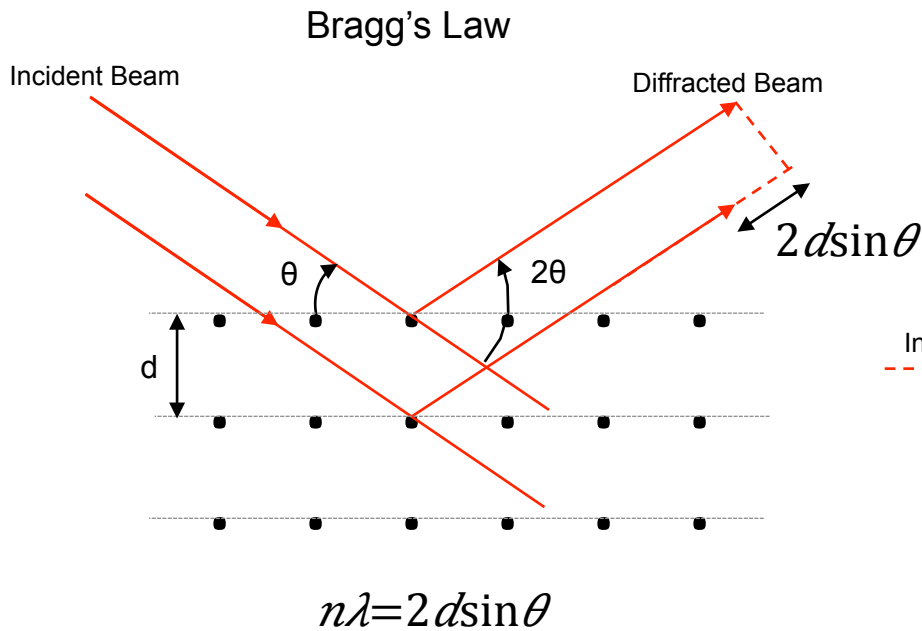
- Understanding different aspects of the problem
- Developing analysis techniques
- Having the toolsets to tackle the problem!

**The handout / tutorial is designed to give you the toolset you require to tackle the problem**



## GENERAL HIGH ENERGY X-RAY DIFFRACTION MICROSCOPY (HEDM) POINTS:

- Use synchrotron x-rays
- All techniques based on Bragg's Law
- Assume kinematic diffraction (generally)





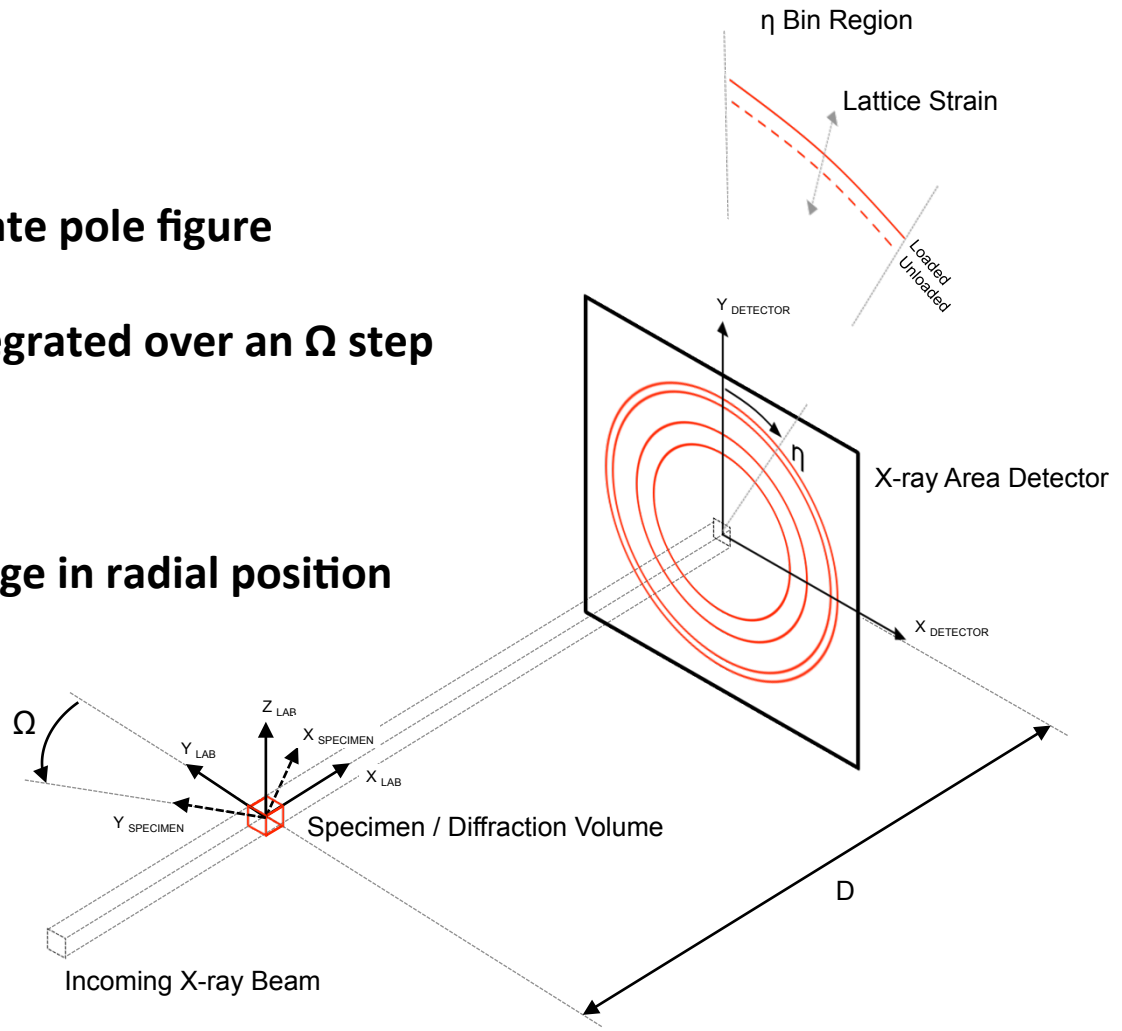


## HEDM EXPERIMENTAL TECHNIQUES:

- **Strain pole figures experiments:**
  - Fiber averaged lattice strains
  - High lattice strain resolution
  - No spatial information
  
- **Far-field experiments:**
  - Orientation, position and lattice strains from individual grains
  - High lattice strain resolution
  - Low spatial resolution
  
- **Near-field experiments:**
  - Orientation and position from sub-grain regions
  - No lattice strain information
  - High spatial resolution

## STRAIN POLE FIGURE EXPERIMENT:

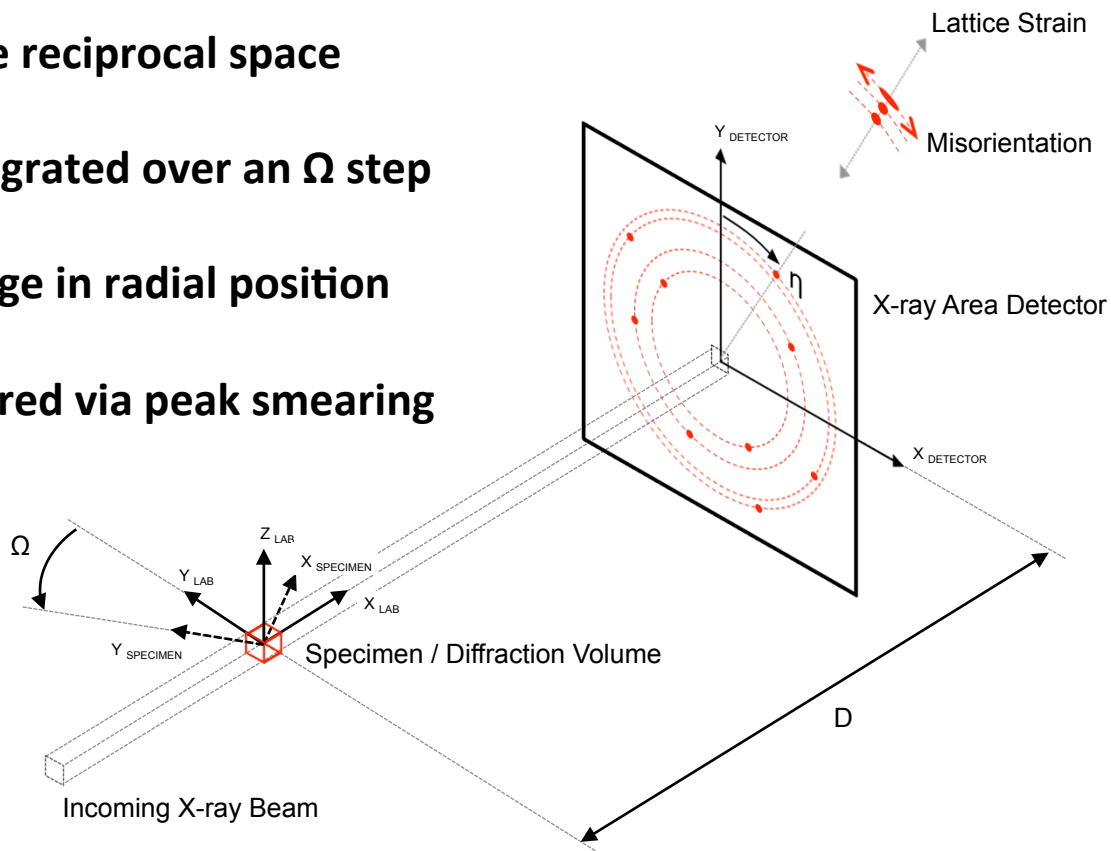
- Powder diffraction rings
- Specimen rotated in  $\Omega$  to populate pole figure
- Intensity of diffracted beam integrated over an  $\Omega$  step
- Detector binned into  $\eta$  regions
- Lattice strain measured via change in radial position
- Back projection
- Analysis is complicated
- Computationally cheap





## FAR-FIELD EXPERIMENT:

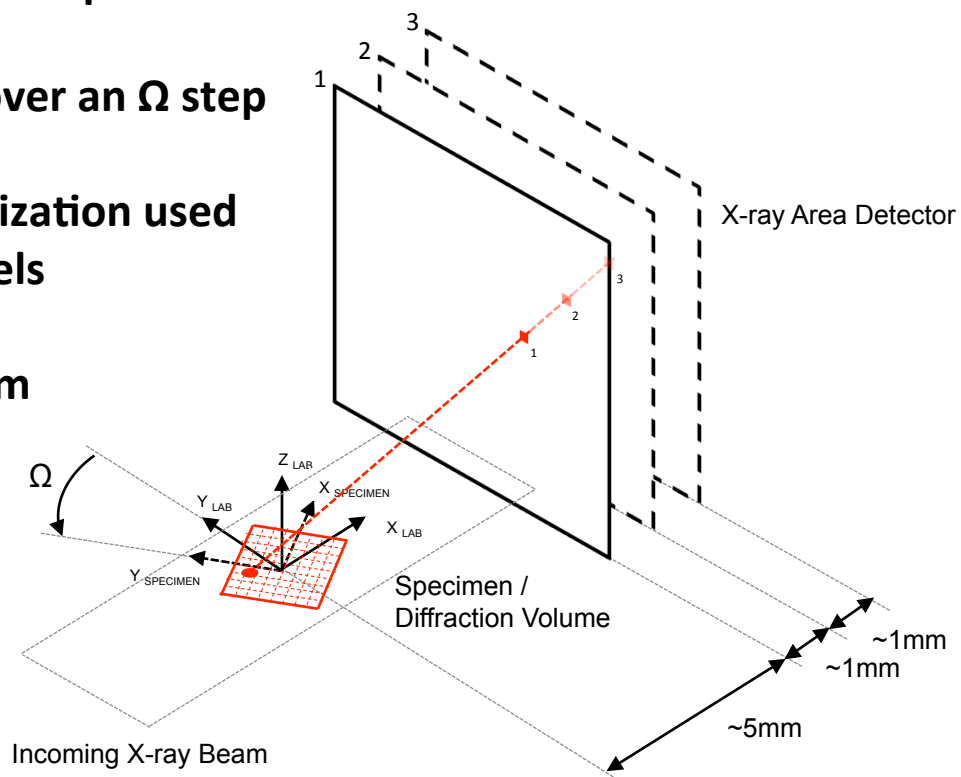
- Multiple diffraction peaks from individual grains
- Specimen rotated in  $\Omega$  to sample reciprocal space
- Intensity of diffracted beam integrated over an  $\Omega$  step
- Lattice strain measured via change in radial position
- Misorientation evolution measured via peak smearing
- Back projection
- Analysis is complicated
- Computationally cheap





## NEAR-FIELD EXPERIMENT:

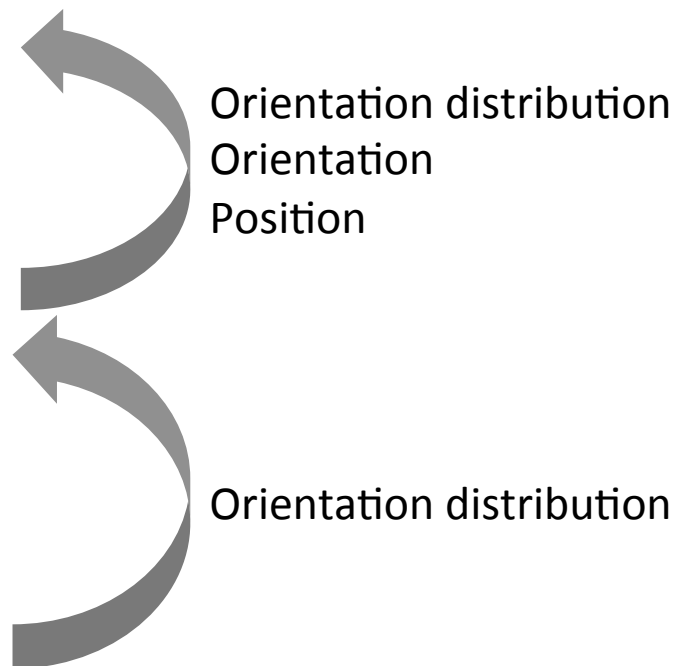
- Multiple diffraction peaks from sub-grain regions
- Specimen rotated in  $\Omega$  to sample reciprocal space
- Intensity of diffracted beam integrated over an  $\Omega$  step
- Forward projection + Monte Carlo optimization used to determine orientation of discrete voxels
- Multiple detector positions + planar beam
- Forward projection
- Analysis is (relatively) easy
- Computationally expensive





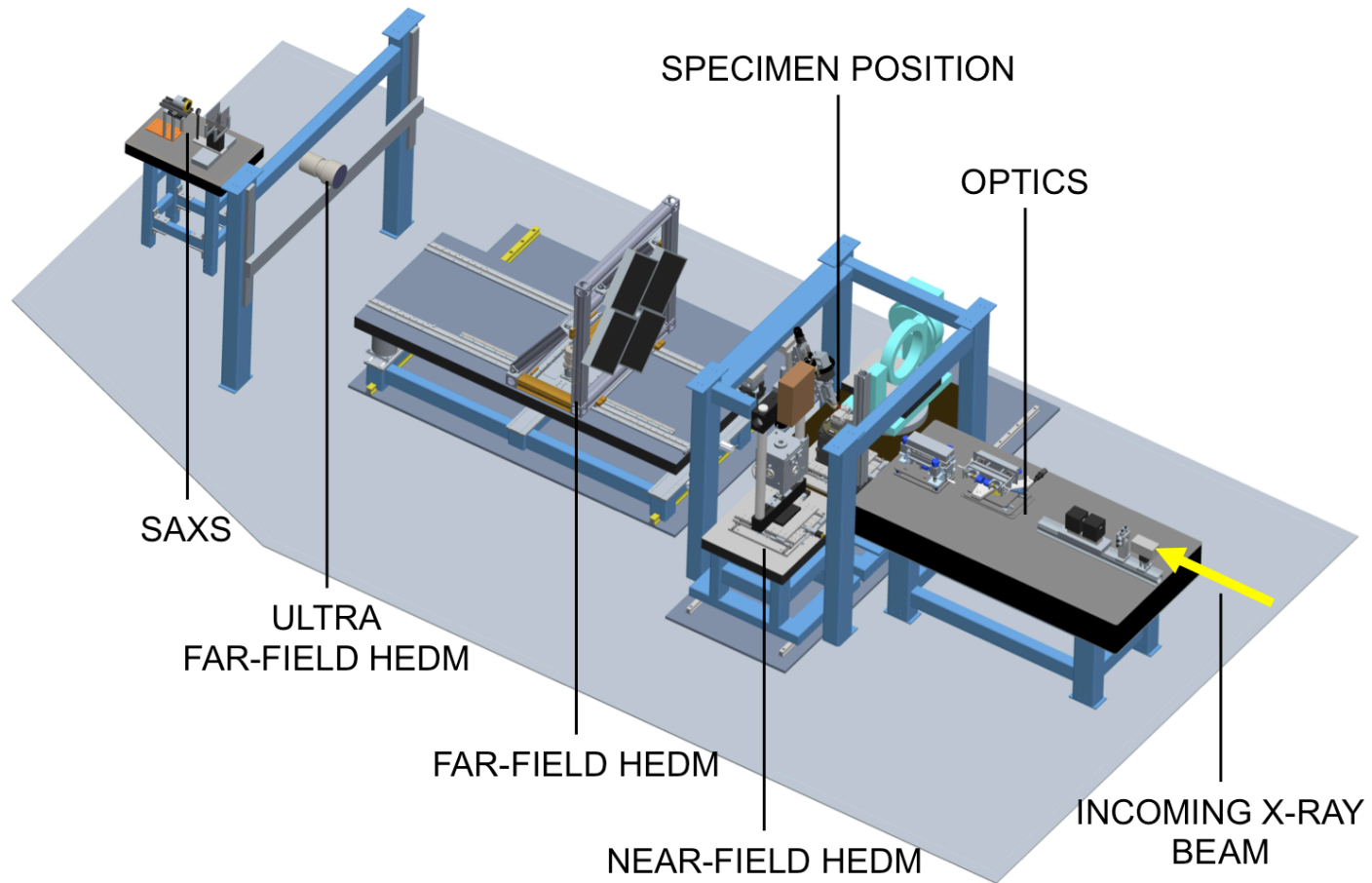
## THE OVERALL COMBINED HEDM VISION:

- **Near-field experiments**
  - Orientation
  - Position
  - Sub-grain resolution
  
- **Far-field experiments**
  - Orientation
  - Position
  - Strain (and therefore stress)
  - Single grain resolution (centroids)
  
- **Lattice strain pole figures experiments**
  - Orientation distribution function
  - Strain (and therefore stress)
  - Fiber averaged resolution





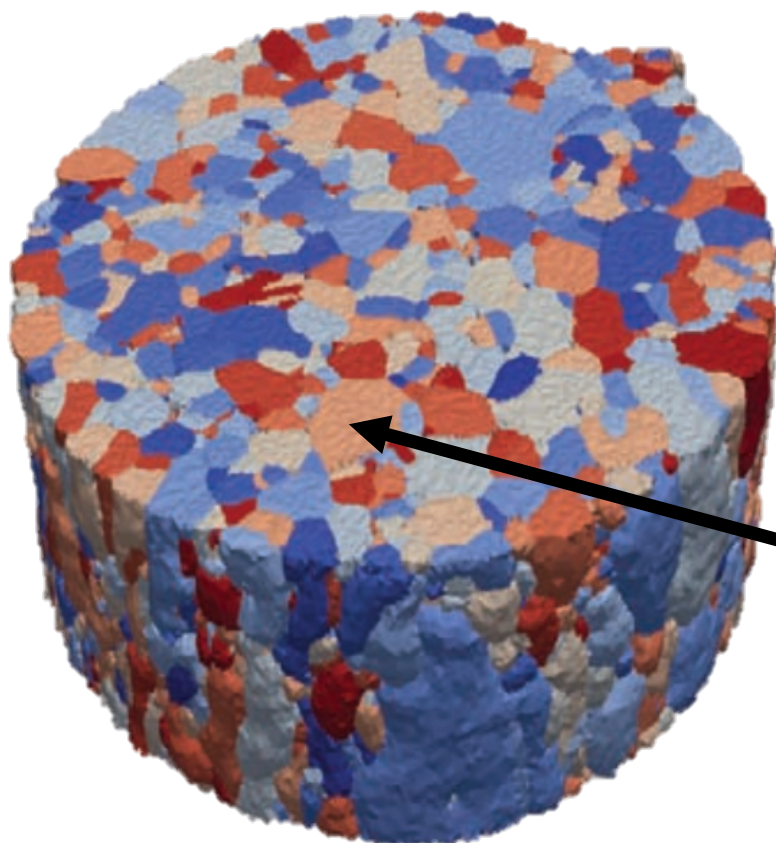
## THE OVERALL COMBINED HEDM VISION:



**Sector 1-ID E-Hutch at the APS (coming online soon)**



## THE OVERALL COMBINED HEDM VISION:



Stress tensor for individual grains

*Example near-field HEDM reconstruction of a polycrystalline specimen of pure Nickel, with colours indicating different crystallographic orientations, diameter = 1mm*



## WHAT YOU NEED TO BE ABLE TO DO HEDM EXPERIMENTS:

- **Good experiment**
- **Instrument corrections / errors**
- **Rotations, orientations and transformations**
- **Stress and strain**
- **Diffraction**
- **Combining it all together**





## STRUCTURE OF THE TUTORIAL:

- **Rotations and orientations**
- **Stress and strain**
- **High-energy x-ray diffraction (powder)**
- **High-energy x-ray diffraction (single crystal)**
- **In-situ high energy diffraction tensile test**

The idea of the handout and tutorial is to give you a structured, step-by-step framework for building up the basic toolsets you require to analyze HEDM data sets, whether they are near-field, far-field or lattice strain pole figures.



**QUESTIONS?**